

Notice of References Cited		Application/Control No. 10/615,020	Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
		Examiner Karen B Addison	Art Unit 2834	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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✓	B	US-6,097,133	08-2000	Shimada et al.	310/358
✓	C	US-6,545,387	04-2003	Lee et al.	310/313A
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	K	US-			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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